

DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

KEY FEATURES

The XDAS-V3 system is the latest version of Sens-Tech X-ray data acquisition systems. New features include:

- Operation by external trigger
- 10 µs minimum integration time
- 43 µs minimum scan time for continuous operation
- 16 bit A/D conversion
- Up to 36000:1 SNR
- Programmable dynamic range from 1.875pC to 60pC in steps of 1.875 pC.
 - * 30pC and 60pC using sub-samples
- Gain can be set for each DH board in the system
- Gain for low energy and high energy channels can be set independently
- Programmable bandwidth limiting to reduce noise

- In-system programmable Xilinx FPGA
- Front-lit detectors
- Read back of status and configuration parameters
- Programmable integration time in steps of 1us
- Separate integration times for low and high energy
- USB 2.0, GigE or parallel interfaces to host
- X-ray energy range 5 keV to 320 keV
- * higher energy range is covered by suitable combination of photodiode and scintillator
- Software API supporting Windows and Linux







DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

DESCRIPTION

XDAS-V3 is a modular system of boards for data acquisition in X-ray line-scan, multi-view and CT systems. It consists of detector head (DH) boards, signal processing (SP) boards and host interface board.

A single energy DH board has 128 detector channels. A dual energy system requires separate DH board for low and high energy. Detector boards can be butted end-to-end to form a continuous array over 10 metres in length.

An optional low energy filter is used for enhanced low and high energy separation.

DH boards with 0.4 mm, 1.6 mm and 2.5 mm detector pitch are also available. See separate data sheets.

APPLICATIONS

- Security inspection
- CT Imaging
- Multi-view imaging
- Non-destructive testing
- Food inspection
- Thickness measurement
- Foreign particle detection
- Bone densitometry

- Industrial process control
- Mineral sorting
- Waste sorting



DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

GENERAL SPECIFICATION

INTEGRATION TIME (SINGLE SAMPLE) 10 µs to 50 ms	INTEGRATION TIME (MULTIPLE SAMPLES) 200 ms (max)	
SUB-SAMPLES 1, 2 or 4	POWER SUPPLY INTERFACE BOARD 12V (9V to 30V), 100 mVp-p ripple	
CROSS-TALK (BOARD TO BOARD) <0.01%	CURRENT (TYPICAL) DH: 125 mA to 150mA	
CROSS-TALK (CHANNEL TO CHANNEL) <0.1%	SP: 200mA to 900mA Interface board: 100mA to 500mA	
DATA RATE (MAXIMUM) 48 MB/s	SNR* (ELECTRONIC) 3.75pC 14500:1	
NON-LINEARITY <0.1%	15pC 19000:1 60pC 36000:1	
A/D CONVERSION 16 bits	SNR* (<10PF DETECTOR CAPACITANCE) 3.75pC 10000:1	
DATA OUTPUT 16 bits	15pC 18000:1 60pC 34000:1	
DETECTOR PITCH (MM) 0.8 mm	NUMBER OF CHANNELS up to 21504	
NUMBER OF SP BOARDS up to 7	NUMBER OF DH BOARDS up to 168	

Note 1: Interface board steps down input supply to 6V (max 5A) for SP boards. SP boards provides power to DH boards.

Note 2: SNR is calculated for ADC full scale and bandwidth limiting enabled.



DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

ENVIRONMENTAL SPECIFICATION

TEMPERATURE

Operating 0 to +60 °C

Storage -40 °C to +70 °C

HUMIDITY (NON-CONDENSING)

Operating 30°C 93%

Non-operating 40°C 93%

PRINCIPLES OF OPERATION

Current from the photodiodes is integrated by an ASIC containing 128 charge sensitive amplifiers.

See detector head block diagram. Correlated double sampling is used to minimise low frequency noise and reject offset error. The microcircuit provides a multiplexed serial analogue output to the signal processing board where data is converted into 16-bit format.

Operation is continuous with one set of data being read out whilst the next set is acquired.

Dead time is 1.6 µs at full bandwidth.

The dynamic range of the system is programmable for each DH board and is determined by the storage capacitors within the ASIC. These can be set from 1.25 pF to 10 pF in steps of 1.25 pF, providing charge storage of 1.875 pC to 15 pC in 1.875 pC steps. The dynamic range can be set separately for high and low energy channels.

See system configuration block diagrams, page 11

Multiple sampling facility is available on the SP board. This enables 2 or 4 samples to be added providing a maximum dynamic range of 60 pC.

Integration time can be adjusted in 1µs steps. Low and high energy detectors can be set different integration times enabling fine tuning of the dynamic range for the two detectors.

The operation of the system is controlled by a gate array which provides central intelligence and control signals for signal processing. Control settings are transmitted to the SP board via a serial, USB or GIGE interface. All settings can be stored in non-volatile RAM such that on power-on, the system is initiated in the last mode saved. See signal processing block diagram.



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PRINCIPLES OF OPERATION

See system configuration block diagrams, page 11

A system is assembled by interconnecting multiple DH and SP boards and connecting to a processor via an interface adaptor board. The system data rate (host speed) is programmable from 3.0 to 48 MB/s. See system block diagram.

DATA ACQUISITION RATE AND POWER

Signal integration time in a typical line scan application is as calculated using following formula:

Integration time (ms) = pixel width (mm)/belt speed (m/s)

Example: integration time setting for 0.8mm pixel width scanning at 1m/s belt speed shall be 0.8 / 1 = 0.8 ms

Speed of operation is normally limited by processing speed of an SP board. Two speeds are available. The SP board takes 42.7 µs at 3MSps and 85.4 µs at 1.5MSps to process a DH board. Minimum continuous integration time of a system can be calculated using following formula:

3MSps: Tint (minimum) = $1.6\mu s + (num DH per SP \times 42.7\mu s)$ 1.5MSps: Tint (minimum) = $3.2\mu s + (num DH per SP \times 85.4\mu s)$

Example: minimum integration time for a 9 DH board and 1 SP board system shall be 1.6 + 9x42.7 = 386 μs

Multiple SP boards process DH boards in parallel.

Example: minimum integration time for a 18 DH board and 2 SP board system shall be 1.6 + $\frac{18}{2}$ x 42.7 = 386 µs

Shorter integration time setting will switch electronics to a non-continuous mode. The SP board increases dead time to allow for ADC conversion to complete before starting the next integration cycle.

A total of 258 bytes is read out per DH board. This includes 2 bytes per pixel and 2 header bytes representing SP address and DH address. There are five host bus speed settings avail-able: 3, 6, 12, 24 and 48 MB/s. The host data rate setting must exceed the data being produced by the system. When integration time is longer than Tint (minimum), average host data rate can be calculated using following formula:

Data rate (MB/s) = (258 x numSP X numDH per SP) / Tint (us)



DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

DATA ACQUISITION RATE AND POWER

Example: data rate for a system of 2 SP boards and 9 DH boards at 500us integration time shall be (258 \times 2x9) / 500 = 9.3MB/s. Therefore, host bus speed should be set to 12MHz.

Example: current requirement for a system of 2 SP boards, 18 DH boards and 1 interface board shall be: $(2 \times 900\text{mA}) + (18 \times 150\text{mA}) + (1 \times 500\text{mA}) = 5\text{A}$.

HOST DATA INTERFACE

Four types are available, providing the following interfaces.

1.

Parallel RS485 output using up to 50 metre SCSI cable connecting to:

- USB 2.0 converter
- GIGE converter
- PCI7300 card, via an RS485 to TTL converter

2.

Local USB 2.0 output connecting to:

- laptop, PC or a single board computer
- USB 2.0 extender using fibre optic or CAT5 cable

3.

Local GIGE output connecting to:

- laptop, PC or a single board computer
- UDP protocol over 1000 BASE-T data link

4.

Channel Link (Camera Link)

- 2.2 Gb/s data rate
- Interface to Active Silicon AS-PHX-D48CL-PE4 frame grabber



DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

EVALUATION SYSTEM

An evaluation system is available, consisting of a detector head board, signal processing board, RS485/USB/GIGE output and evaluation software. This is mounted in a test box (LINX type, see data sheet) to provide electrical and radiation screening.

Demonstration software is available via download link or on a CD or download link and can be loaded on to a Windows PC (Pentium 4 or later) to check basic function of the system. A high speed USB 2.0 or Gigabit Ethernet port is required for the host interface. The software enables setting of gain and integration time and single lines of data to be acquired.

Data can be logged to a csv file and can be displayed in graphical form. Gain and offset correction can be applied via the software.

Imaging Application is available, contact Sens-Tech for details

ORDERING INFORMATION

DETECTORS

Detector selection is an important part of system design. Parameters are stopping power, light output and signal decay time. Fast decay time is particularly important in CT systems.

An overview of typical scintillation materials with the main parameters is presented on page 15.



DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

ORDERING INFORMATION

DETECTOR HEAD BOARDS

DETECTOR HEAD BOARDS

0.8 mm pitch standard width

0.8 mm pitch narrow width

PART NUMBER	DESCRIPTION	PART NUMBER	DESCRIPTION
XDAS-DH3-0210	no detectors	XDAS-DH3-8210	no detectors
XDAS-DH3-0211	Gadox	XDAS-DH3-8211	Gadox
XDAS-DH3-0212	Csl	XDAS-DH3-8212	Csl
XDAS-DH3-0213	CdWO4	XDAS-DH3-8213	CdWO4
XDAS-DH3-0214	Silicon	XDAS-DH3-8214	Silicon



DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

ORDERING INFORMATION

SIGNAL PROCESSING BOARD

INTERFACE OPTIONS

PART NUMBER

PART NUMBER	DESCRIPTION
XDAS-SP3-01	signal processing board (sandard)
XDAS-SP3-801	signal processing board (narrow)

TERMINATORS AND ADAPTORS

DESCRIPTION
Local bus (standard)
Local bus (narrow)
System bus
DH3-8xx adaptor to XDAS-SP3-01 (DH1 to 12)
DH3-8xx adaptor to XDAS-SP3-01 (DH13 to 24)
Belt encoder processing board

XDAS-485A-V3	parallel RS485 over 50 way SCSI cable, board only
XDAS-USB2-1-V3	USB2 interface with USB connector, power connector and LED
XDAS-USB2-2-V3	USB2 interface board only
XDAS-USB2-3-V3	USB2 interface with USB connector LED
XDAS-USB2-4-V3	USB2 interface with USB connector
XDAS-GIGE-V3	GIGE interface board only
XDAS-GIGE-V3-1	GIGE interface, with RJ45 connector, power connector and LED
XDAS-GIGE-V3-3	GIGE interface with RJ45 and LED
XDAS-GIGE-V3-4	GIGE interface with RJ45 connector
XDAS-USB2	remote RS485 to USB converter
XDU-INT-SGI	remote RS485 to GIGE converter

DESCRIPTION

Note: interface boards step down input supply to 6V for supply to SP board (max 5A).



DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

ORDERING INFORMATION

CABLES

Note: see system configuration section or contact Sens-tech for cable part numbers

PART NUMBER	DESCRIPTION	PART NUMBER	DESCRIPTION
Detector board (standard)	50way 2mm pitch IDC	Detector board (narrow)	50way 1.27mm pitch IDC
CABLE-XDASPCBxx	Data cable (specify length)	Signal processing board	50way 1.27mm pitch IDC
CABLE-XDASPCB21	48mm	CABLE-XDASPCBxx	Data cable (specify length)
CABLE-XDASPCB22	75mm	CABLE-XDASPCB24	100mm
CABLE-XDASPCB17	100mm	CABLE-XDASPCB25	175mm
CABLE-XDASPCB23	110mm	CABLE-XDASPCB26	200mm
CABLE-XDASPCB18	200mm	CABLE-XDASPWR2-xx	Power cable from GIGE
CABLE-XDASPCB19	300mm		(specify length)
CABLE-XDASPCB20	400mm	CABLE-XDASPWR2-02	500mm
		CABLE-XDASLED-01	Bulkhead diagnostic LED 20cm

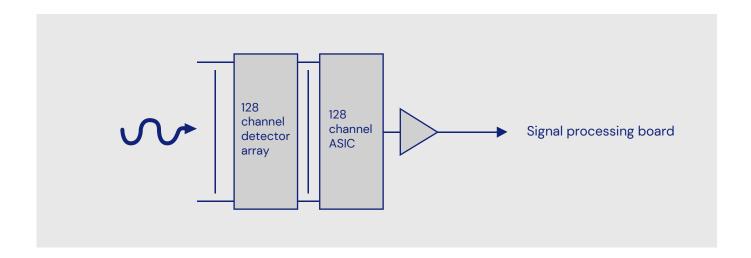
SOFTWARE

PART NUMBER	DESCRIPTION
XDAS-SOFTWARE	evaluation software and SDK

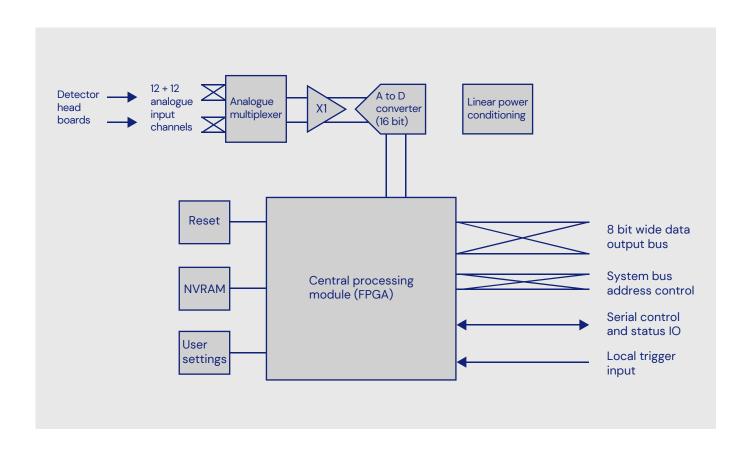


DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

DETECTOR HEAD BLOCK DIAGRAM



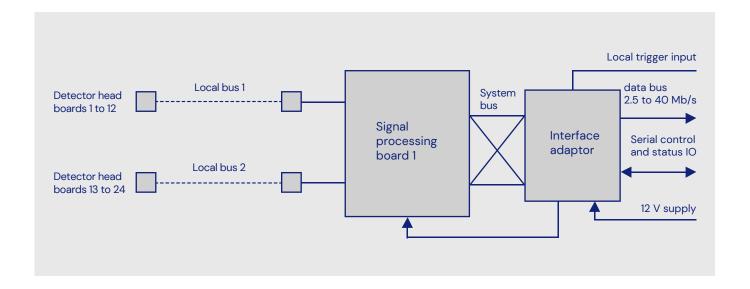
SIGNAL PROCESSING BLOCK DIAGRAM





DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

SYSTEM BLOCK DIAGRAM

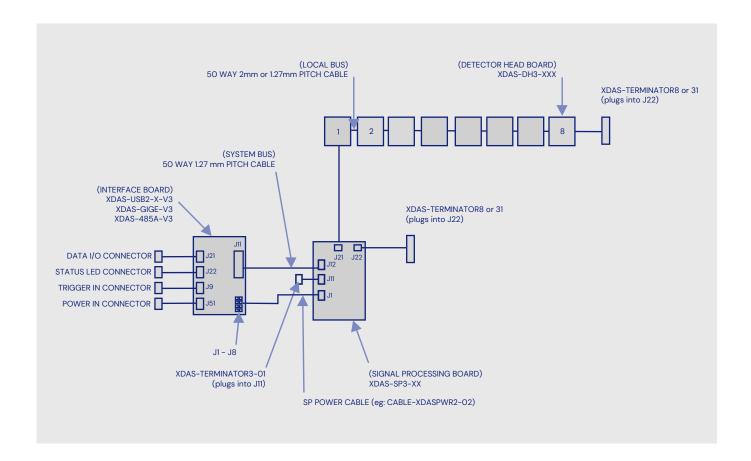




DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

SYSTEM CONFIGURATION

SINGLE SP BOARD



Notes:-

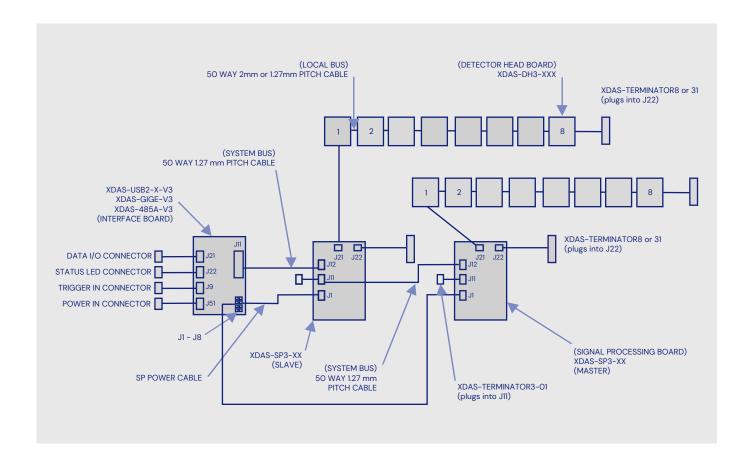
- 1. Custom cable lengths available upon request
- 2. Narrow format boards use 1.27mm pitch connectors and 0.635 mm cable
- 3. Interface boards are supplied with connectors upon request
- 4. XDAS-terminator3-01 is connected to master SP board for systems with multiple SP boards



DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

SYSTEM CONFIGURATION

MULTIPLE SP BOARD



Notes:-

- 1. Custom cable lengths available upon request
- 2. Narrow format boards use 1.27mm pitch connectors and 0.635 mm cable
- 3. Interface boards are supplied with connectors upon request
- 4. XDAS-terminator3-01 is connected to master SP board for systems with multiple SP boards



DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

DETECTORS

TYPE OF SCINTILLATOR	THICKNESS	ENERGY RANGE	SIGNAL OUTPUT PER UNIT ENERGY	DECAY TIME CONSTANT	COMMENTS
Silicon	0.3 mm	5 - 30 keV	highest	1 µs for unbiased diode	Direct conversion, no scintillator cost
Gadox (Tb)	0.2 mm 0.3 mm 0.4 mm	20 - 120 keV	20% lower similar to CSI 20% lower	<1 ms 2 - 3 ms <1 ms	Phosphor strip
Csl	2.5 mm	40 - 160 keV	best light output	2 components, slow decay of secondary component (seconds)	Pixelated arrays to reduce crosstalk
CdW04	2.5 mm	80 - 320 keV	25% of CSI	20 μs	Pixelated arrays, highest cost material

Note 1: Thicknesses shown are of standard products. Other thicknesses are available on order which will cover wide energy ranges

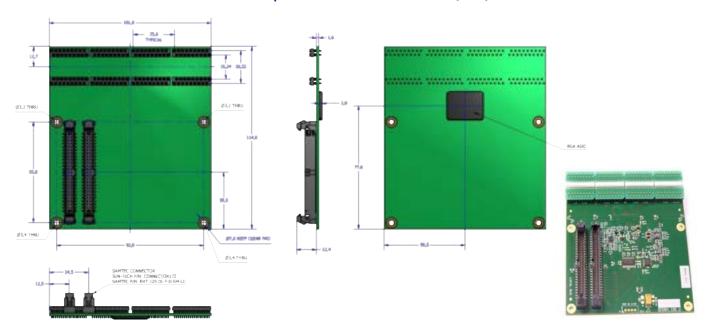


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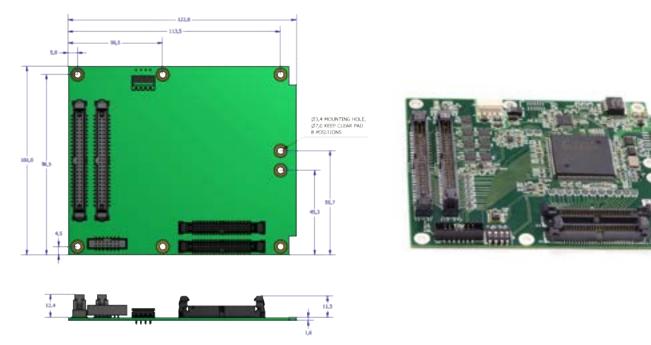
Note: Following drawings are for reference only. Contact Sens-tech for latest mechanical drawings and 3D CAD models.

OUTLINE DRAWINGS

XDAS-DH3-2x Standard footprint detector head board (mm)



XDAS-SP3-01 Standard footprint signal processing board (mm)



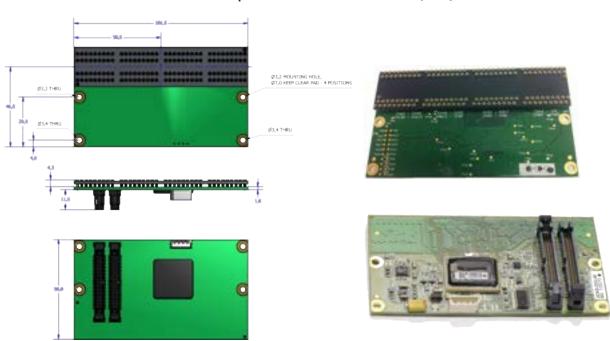


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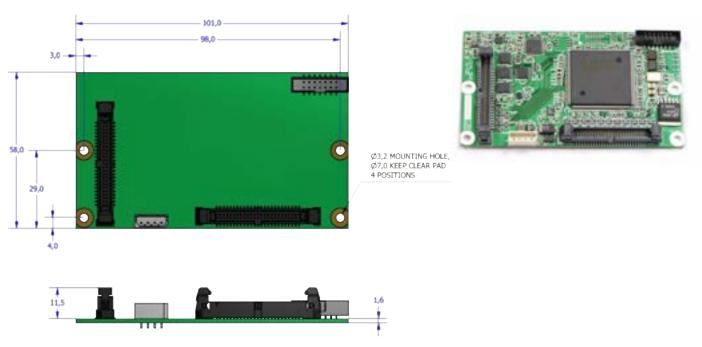
Note: Following drawings are for reference only. Contact Sens-tech for latest mechanical drawings and 3D CAD models.

OUTLINE DRAWINGS CONTINUED...

XDAS-DH3-82x Small footprint detector head board (mm)



XDAS-SP3-801 Small footprint signal processing board (mm)



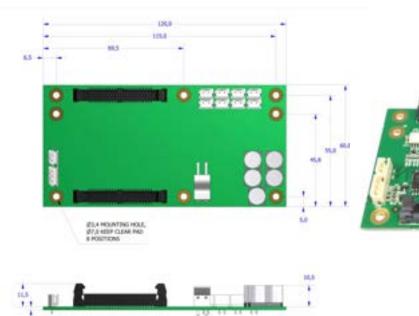


DUAL ENERGY X-RAY DATA ACQUISITION SYSTEM

Note: Following drawings are for reference only. Contact Sens-tech for latest mechanical drawings and 3D CAD models.

OUTLINE DRAWINGS CONTINUED...

XDAS-485A-V3 Interface board

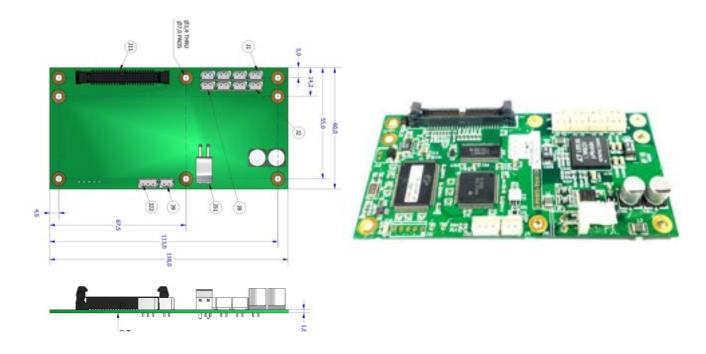






XDAS-USB2-x-V3

Interface board



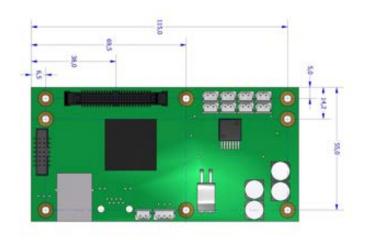


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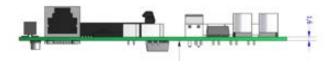
Note: Following drawings are for reference only. Contact Sens-tech for latest mechanical drawings and 3D CAD models.

OUTLINE DRAWINGS CONTINUED...

XDAS-GIGE-V3 Interface board







LED STATUS MNEMONICS

	LED INDICATION	MEANING (USB)	MEANING (GIGE)
	Green	Idle	Idle
	Green (Flashing)	Acquiring data	Acquiring data
	Amber	Data buffer overflow. (Idle)	Connected to 100Mbps link. Not yet supported
V	Amber (Flashing)	Data buffer overflow. (Acquiring)	Command received from host
	Red/Green (Alternating)	System under reset	System under reset
	Red [1]	Microcontroller not responding	Device fault. Contact support
	Red [1] (Flashing ~1Hz)	USB endpoint has stalled	Ethernet Link is not connected
	Red [1] (Flashing >4Hz)	Could not enumerate as USB2.0 device	Ethernet link fault
	Off	Power off, un-programmed or other fault	Power off, un-programmed or other fault

SENS-TECH

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